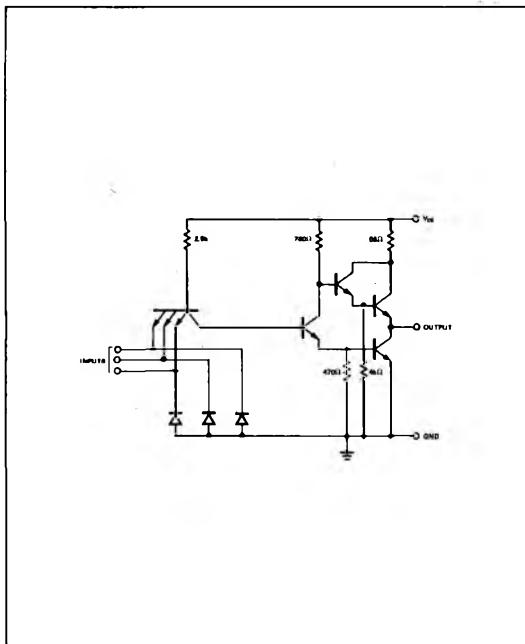
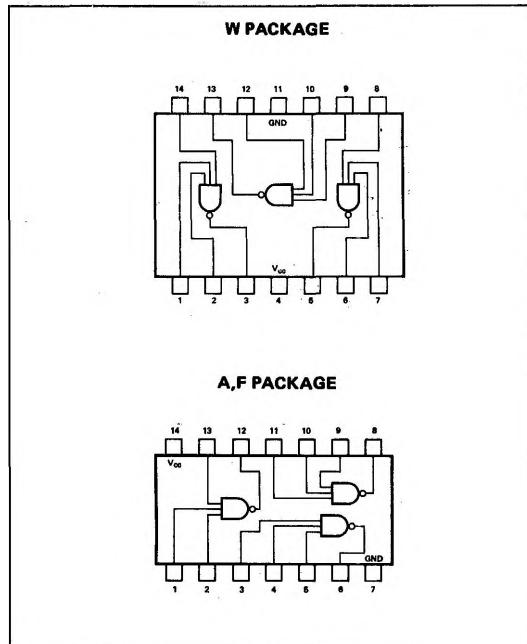


**SCHEMATIC (each gate)**



**PIN CONFIGURATIONS**



**RECOMMENDED OPERATING CONDITIONS**

		MIN	NOM	MAX	UNIT
Supply Voltage $V_{CC}$ :	S54H10 Circuits	4.5	5	5.5	V
	N74H10 Circuits	4.75	5	5.25	V
Normalized Fan-Out from each Output, N				10	
Operating Free-Air Temperature Range, $T_A$ :	S54H10 Circuits	-55	25	125	$^{\circ}\text{C}$
	N74H10 Circuits	0	25	70	$^{\circ}\text{C}$

**ELECTRICAL CHARACTERISTICS** (over recommended operating free-air temperature range unless otherwise noted)

PARAMETER	TEST CONDITIONS*	TEST CONDITIONS*			UNIT
		MIN	TYP**	MAX	
$V_{in(1)}$	Logical 1 input voltage required at all input terminals to ensure logical 0 level at output	$V_{CC} = \text{MIN}$ ,		2	V
$V_{in(0)}$	Logical 0 input voltage required of any input terminal to ensure logical 1 level at output	$V_{CC} = \text{MIN}$ ,		0.8	V
$V_{out(1)}$	Logical 1 output voltage	$V_{CC} = \text{MIN}$ , $I_{load} = -500\mu\text{A}$	$V_{in} = 0.8\text{V}$ ,	2.4	V
$V_{out(0)}$	Logical 0 output voltage	$V_{CC} = \text{MIN}$ , $I_{sink} = 20\text{mA}$	$V_{in} = 2\text{V}$ ,	0.4	V
$I_{in(0)}$	Logical 0 level input current (each input)	$V_{CC} = \text{MAX}$ ,	$V_{in} = 0.4\text{V}$	-2	$\text{mA}$
$I_{in(1)}$	Logical 1 level input current (each input)	$V_{CC} = \text{MAX}$ , $V_{CC} = \text{MAX}$ , $V_{in} = 2.4\text{V}$	$V_{in} = 5.5\text{V}$	50 1	$\mu\text{A}$ $\text{mA}$
$I_{OS}$	Short circuit output current†	$V_{CC} = \text{MAX}$		-40	-100

# DIGITAL 54/74 TTL SERIES ■ S54H10, N74H10

## ELECTRICAL CHARACTERISTICS (Cont'd)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
$I_{CC(0)}$	Logical 0 level supply current $V_{CC} = \text{MAX}$ , $V_{in} = 4.5V$		19.5	30	mA
$I_{CC(1)}$	Logical 1 level supply current $V_{CC} = \text{MAX}$ , $V_{in} = 0$		7.5	12.6	mA

SWITCHING CHARACTERISTICS,  $V_{CC} = 5V$ ,  $T_A = 25^\circ\text{C}$ ,  $N = 10$

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
$t_{pd0}$	Propagation delay time to logical 0 level $C_L = 25\text{pF}$ , $R_L = 280\Omega$		6.3	10	ns
$t_{pd1}$	Propagation delay time to logical 1 level $C_L = 25\text{pF}$ , $R_L = 280\Omega$		5.9	10	ns

\* For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable device type.

\*\* All typical values are at  $V_{CC} = 5V$ ,  $T_A = 25^\circ\text{C}$ .

† Not more than one output should be shorted at a time and duration of short circuit test should not exceed 1 second.